







INA253-Q1

ZHCSK07A - JULY 2019 - REVISED JANUARY 2021

# 符合 AEC-Q100 标准、具有 PWM 抑制功能和集成分流电阻器的 INA253-Q1 80V、双向精密电流感应放大器

## 1 特性

- 符合面向汽车应用的 AEC-Q100 标准:
  - 温度等级 1: -40°C 至 +125°C, TA
- 提供功能安全
  - 可帮助进行功能安全系统设计的文档
- 精密集成型分流电阻器
  - 分流电阻器: 2mΩ
  - 分流电感:3nH
  - 分流电阻器容差: 0.1%(最大值)
  - 在 40°C 至 +85°C 范围内具有 ±15A 持续电流
  - 0°C 至 125°C 温度系数: 10ppm/°C
- 高带宽:350kHz
- 增强型 PWM 抑制
- 出色的 CMRR
  - 直流 CMRR 大于 120dB
  - 90dB AC CMRR (50kHz 时)
- 精度:
  - 増益:

增益误差:0.4%(最大值) • 增益漂移: 45ppm/°C(最大值)

- 失调电压:

• 失调电流:±15mA(最大值) • 温漂:125µA/°C(最大值)

宽共模范围:-4V 至 +80V

• 可用增益:100mV/A、200mV/A

和 400mV/A

• 静态电流: 2.4mA(最大值)

## 2 应用

- 柴油发动机
- 汽油发动机
- 阀门或电机传动器
- 自动变速器
- 手动变速器
- 动力系统电流传感器

## 3 说明

INA253-Q1 是一款具有 2mΩ 集成分流电阻器的汽车 类电压输出、电流检测放大器。INA253-Q1 可独立于 电源电压在 - 4V 至 +80V 的宽共模范围内监控双向电 流。 共 有 三 种 固 定 增 益 可 供 选 择 : 100mV/A、 200mV/A 和 400mV/A。通过将精密电阻器和零漂移斩 波放大器进行整合,可以为感应电阻器提供校准等效测 量精度、15ppm/°C的超低温漂性能和优化的开尔文布

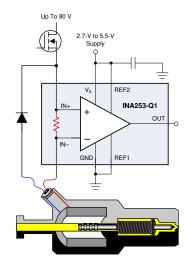
INA253-Q1 采用了增强型 PWM 抑制电路,可抑制较 大的 (dv/dt) 信号,从而实现实时持续电流测量。这种 测量对于电机驱动应用中的线路内电流测量以及电磁阀 控制应用至关重要。

该器件由 2.7V 至 5.5V 的单电源供电运行,消耗的最 大电源电流为 3mA。所有增益版本的额定工作温度范 围均为 -40°C 至 +125°C, 并采用 20 引脚 TSSOP 封 装。

## 器件信息(1)

器件型号	封装	封装尺寸(标称值)
INA253-Q1	TSSOP (20)	6.50mm × 4.40mm

如需了解所有可用封装,请参阅产品说明书末尾的封装选项附



典型应用



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# **4 Revision History**

С	hanges from Revision * (July 2019) to Revision A (January 2021)	Page
•	更新了整个文档的表、图和交叉参考的编号格式	1
•	添加了"提供功能完全"项目符号	1



# **Device Comparison Table**

PRODUCT	GAIN (mV/A)
INA253A1-Q1	100
INA253A2-Q1	200
INA253A3-Q1	400

# **5 Pin Configuration and Functions**

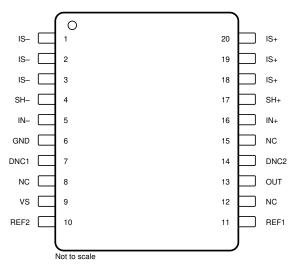


图 5-1. PW Package 20-Pin TSSOP Top View

表 5-1. Pin Functions

	PIN I/O		DESCRIPTION		
NO.	NAME	- 1/0	DESCRIPTION		
1	IS -	Analog input	Connect to load		
2	IS -	Analog input	Connect to load		
3	IS -	Analog input	Connect to load		
4	SH -	Analog output	Kelvin connection to internal shunt. Connect to IN - if no filtering is needed		
5	IN -	Analog input	Voltage input from load side of shunt resistor		
6	GND	_	Ground		
7	DNC1	_	Do not connect this pin to any potential; leave this pin floating.		
8	NC	_	No connect		
9	VS	Analog	Power supply, 2.7 V to 5.5 V		
10	REF2	Analog input	Reference voltage 2, 0 V to VS		
11	REF1	Analog input	Reference voltage 1, 0 V to VS		
12	NC	_	No connect		
13	OUT	Analog	Output voltage		
14	DNC2	_	Do not connect this pin to any potential; leave this pin floating.		
15	NC	Analog	Reserved; connect this pin to ground		
16	IN+	Analog input	Voltage input from supply side of shunt resistor		
17	SH+	Analog output	Kelvin connection to internal shunt. Connect to IN+ if no filtering is needed		
18	IS+	Analog input	Connect to supply		
19	IS+	Analog input	Connect to supply		
20	IS+	Analog input	Connect to supply		



## **6 Specifications**

## **6.1 Absolute Maximum Ratings**

over operating free-air temperature range (unless otherwise noted)(1)

		MIN	MAX	UNIT
Supply voltage			6	V
Shunt input current (I <sub>SENSE</sub> )	Continuous		±15	Α
Analog inputs (IS+, IS - )	Common-mode	GND - 6	90	V
Analog inputs (V <sub>IN+</sub> ,V <sub>IN -</sub> )	Differential (V <sub>IN+</sub> ) - (V <sub>IN-</sub> )	- 80	80	V
Analog Inputs (V <sub>IN+</sub> , V <sub>IN -</sub> )	Common-mode	GND - 6	90	
Analog inputs (REF1, REF2, NC)		GND - 0.3	V <sub>S</sub> + 0.3	V
Analog outputs (SH+, SH - )	Common-mode	GND - 6	90	V
Analog output (OUT)		GND - 0.3	V <sub>S</sub> + 0.3	V
	Operating, T <sub>A</sub>	- 55	150	
Temperature	Junction, T <sub>J</sub>		150	°C
	Storage, T <sub>stg</sub>	- 65	150	

<sup>(1)</sup> Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

## 6.2 ESD Ratings

			VALUE	UNIT
	Human body model (HBM), per AEC Q100-002 <sup>(1)</sup> HBM ESD Classification Level 2	±3000	\ \ \	
V <sub>(ESD)</sub>	Electrostatic discharge	Charged device model (CDM), per AEC Q100-011 CDM ESD Classification Level C6	±1000	

<sup>(1)</sup> AEC Q100-002 indicates that HBM stressing shall be in accordance with the ANSI/ESDA/JEDEC JS-001 specification.

#### 6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

		MIN	NOM MAX	UNIT
V <sub>CM</sub>	Common-mode input voltage	- 4	80	V
Vs	Operating supply voltage	2.7	5.5	V
T <sub>A</sub>	Operating free-air temperature	- 40	125	$^{\circ}$

## **6.4 Thermal Information**

		INA253-Q1	
	THERMAL METRIC <sup>(1)</sup>		UNIT
		20 PINS	
R <sub>0</sub> JA	Junction-to-ambient thermal resistance	110.6	°C/W
R <sub>fl</sub> JC(top)	Junction-to-case (top) thermal resistance	54.1	°C/W
R <sub>0</sub> JB	Junction-to-board thermal resistance	87.5	°C/W
ΨJT	Junction-to-top characterization parameter	114.1	°C/W
ψ ЈВ	Junction-to-board characterization parameter	87.5	°C/W

<sup>(1)</sup> For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.

Product Folder Links: INA253-Q1



## **6.5 Electrical Characteristics**

at  $T_A = 25$  °C,  $V_S = 5$  V,  $I_{SENSE} = IS + = 0$  A,  $V_{CM} = 12$  V, and  $V_{REF1} = V_{REF2} = V_S / 2$  (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
INPUT						
V <sub>CM</sub>	Common-mode input range	V <sub>IN+</sub> = -4 V to +80 V, I <sub>SENSE</sub> = 0 A, T <sub>A</sub> = -40 °C to +125 °C	- 4		80	V
CMR	Common-mode rejection	V <sub>IN+</sub> = -4 V to +80 V, I <sub>SENSE</sub> = 0 A, T <sub>A</sub> = -40 °C to +125 °C		±125	±500	μA/V
		f = 50 kHz		±13		mA/V
los	Offset current, input-referred	I <sub>SENSE</sub> = 0 A		±2.5	±15	mA
dl <sub>OS</sub> /dT	Offset current drift	I <sub>SENSE</sub> = 0 A, T <sub>A</sub> = -40 °C to +125 °C		25	125	μΑ/°C
PSRR	Power-supply rejection ratio	V <sub>S</sub> = 2.7 V to 5.5 V, I <sub>SENSE</sub> = 0 A		±0.5	±5	mA/V
I <sub>B</sub>	Input bias current	I <sub>B+</sub> , I <sub>B-</sub> , I <sub>SENSE</sub> = 0 A		90		μA
	Reference input range		0		Vs	V
SHUNT	RESISTOR			,		
R <sub>SHUNT</sub>	Shunt resistance (SH+ to SH - )	Equivalent resistance when used with onboard amplifier	1.998	2	2.002	mΩ
		Used as stand-alone resistor <sup>(1)</sup>	1.9	2	2.1	
	Package resistance	IS+ to IS -		4.5		mΩ
	Package inductance	IS+ to IS -		3		nH
	Resistor temperature coefficient	T <sub>A</sub> = -40 °C to +125 °C		15		
		T <sub>A</sub> = -40 °C to 0 °C		50		ppm/°
		T <sub>A</sub> = 0 °C to 125 °C		10		
I <sub>SENSE</sub>	Maximum continuous current <sup>(2)</sup>	T <sub>A</sub> = -40 °C to +85 °C		,	±15	Α
	Shunt short time overload	I <sub>SENSE</sub> = 30 A for 5 seconds		±0.05%		
	Shunt thermal shock	- 65 °C to +150°C, 500 cycles		±0.1%		
	Shunt resistance to solder heat	260 °C solder, 10 seconds		±0.1%		
	Shunt high temperature exposure	1000 hours, T <sub>A</sub> = 150 °C		±0.15%		
	Shunt cold temperature storage	24 hours, T <sub>A</sub> = -65 °C		±0.025%		
ОИТРИТ	Г					
		INA253A1		100		
G	Gain	INA253A2		200		mV/A
		INA253A3		400		
	System gain error <sup>(3)</sup>	GND + 50 mV $\leq$ V <sub>OUT</sub> $\leq$ V <sub>S</sub> - 200 mV, T <sub>A</sub> = 25 °C		±0.05%	±0.4%	
		T <sub>A</sub> = -40 °C to +125 °C		,	±45	ppm/°0
	Nonlinearity error	GND + 10 mV $\leq$ V <sub>OUT</sub> $\leq$ V <sub>S</sub> - 200 mV		±0.01%		
	Reference divider accuracy	$V_{OUT} =  (V_{REF1} - V_{REF2})  / 2$ at $I_{SENSE} = 0$ A, $T_A = -40$ °C to +125 °C		0.02%	0.1%	
	Reference voltage rejection ratio (input-	INA253A2		2.5		
RVRR	referred)	INA253A1, INA253A3		1		mA/V
	Maximum capacitive load	No sustained oscillation		1		nF
VOLTAG	SE OUTPUT					
	Swing to V <sub>S</sub> power-supply rail	$R_L = 10 \text{ k}\Omega$ to GND, $T_A = -40 \text{ °C}$ to +125 °C		V <sub>S</sub> - 0.05	V <sub>S</sub> - 0.2	V
	Swing to GND	$R_L$ = 10 kΩ to GND, $I_{SENSE}$ = 0 A, $V_{REF1}$ = $V_{REF2}$ = 0 V, $T_A$ = -40 °C to +125 °C		V <sub>GND</sub> + 1	V <sub>GND</sub> + 10	mV



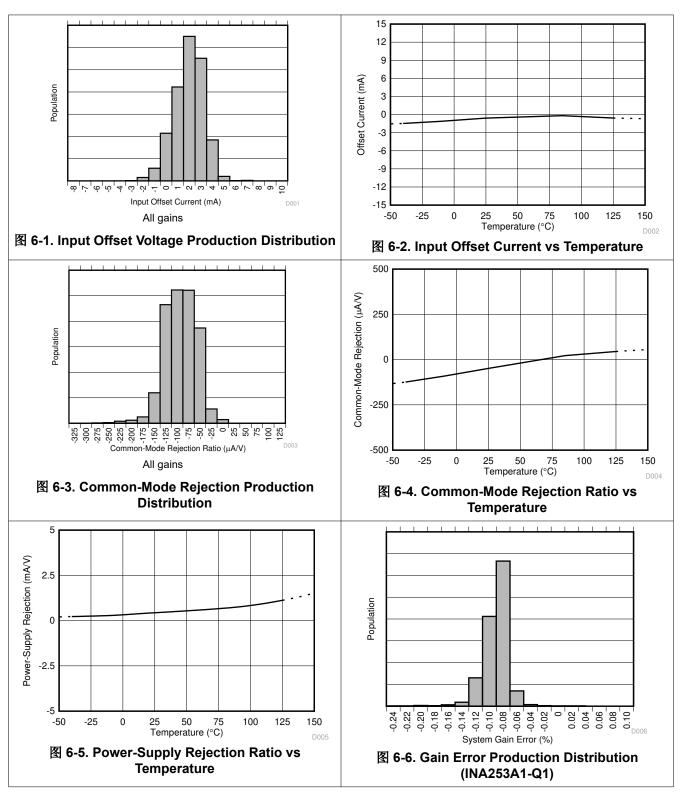
at  $T_A = 25$  °C,  $V_S = 5$  V,  $I_{SENSE} = IS + = 0$  A,  $V_{CM} = 12$  V, and  $V_{REF1} = V_{REF2} = V_S / 2$  (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT	
FREQU	FREQUENCY RESPONSE						
BW	Bandwidth <sup>(4)</sup>	All gains, - 3-dB bandwidth		350		kHz	
DVV	Danuwidin /	All gains, 2% THD+N <sup>(4)</sup>		100		KI IZ	
	Output settling time	Settles to 0.5% of final value		10		μs	
SR	Slew rate			2.4		V/µs	
NOISE	(Input Referred)						
	Voltage noise density			40		nV/ √ <del>Hz</del>	
POWE	POWER SUPPLY						
	Ouisseent current	I <sub>SENSE</sub> = 0 A		1.8	2.4	mA	
IQ	Quiescent current	$T_A = -40  ^{\circ}\text{C} \text{ to } +125  ^{\circ}\text{C}$			2.6	шА	

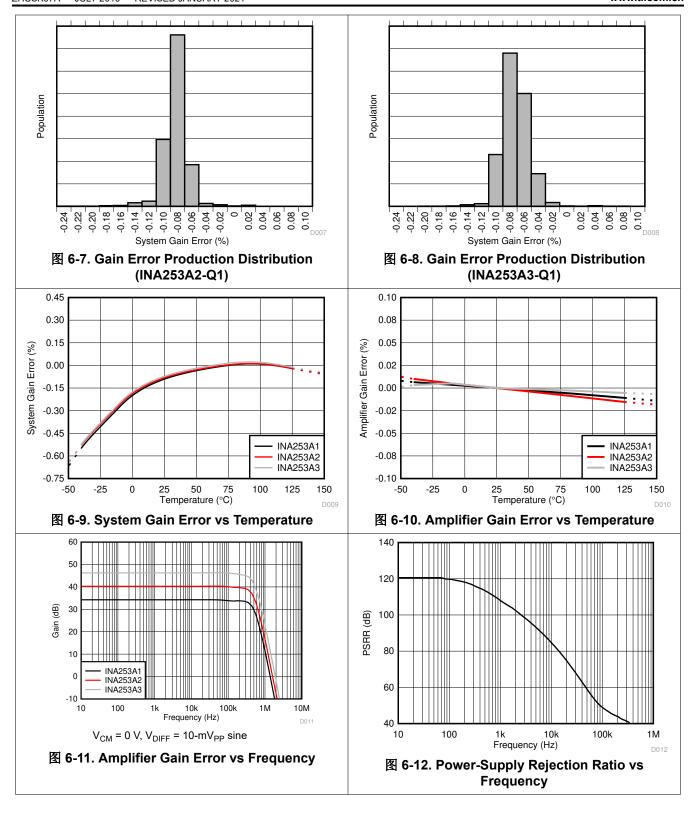
- (1) The internal shunt resistor is intended to be used with the internal amplifier and is not intended to be used as a stand-alone resistor. See the *Integrated Shunt Resistor* section for more information.
- (2) See Maximum Continuous Current for additional information on the current derating and review layout section recommendations to improve the current handling capability of the device at higher temperatures.
- (3) System gain error includes amplifier gain error and the integrated sense resistor tolerance. System gain error does not include the stress related characteristics of the integrated sense resistor. These characteristics are described in the *Shunt Resistor* section of the *Electrical Characteristics* table.
- (4) See Bandwidth section for more details.

## **6.6 Typical Characteristics**

at  $T_A$  = 25 °C,  $V_S$  = 5 V,  $V_{IN+}$  = 12 V, and  $V_{REF}$  =  $V_S$  / 2 (unless otherwise noted)







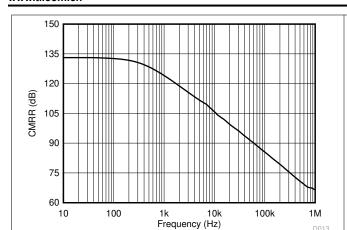


图 6-13. Common-Mode Rejection Ratio vs Frequency

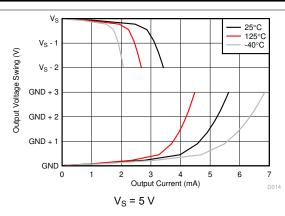


图 6-14. Output Voltage Swing vs Output Current

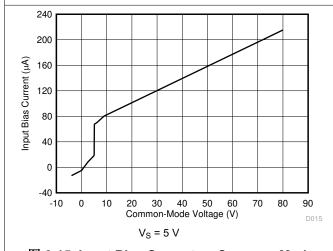


图 6-15. Input Bias Current vs Common-Mode Voltage

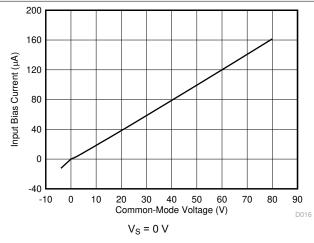
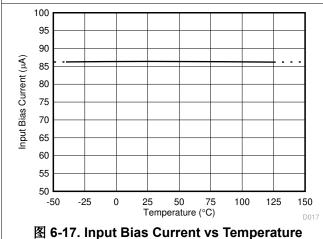


图 6-16. Input Bias Current vs Common-Mode Voltage



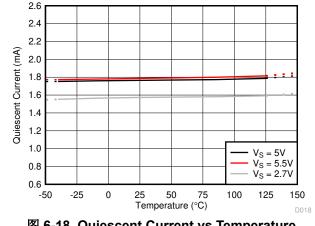
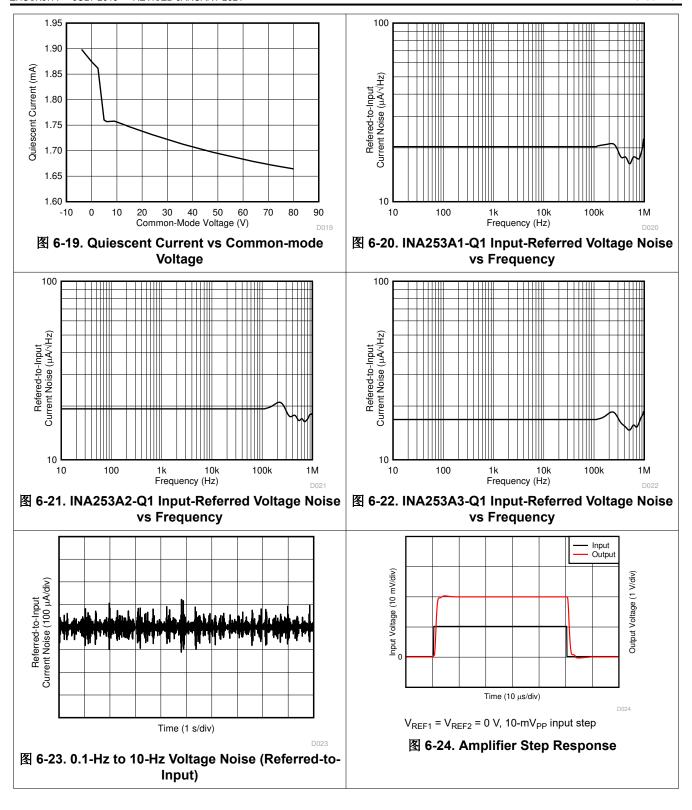
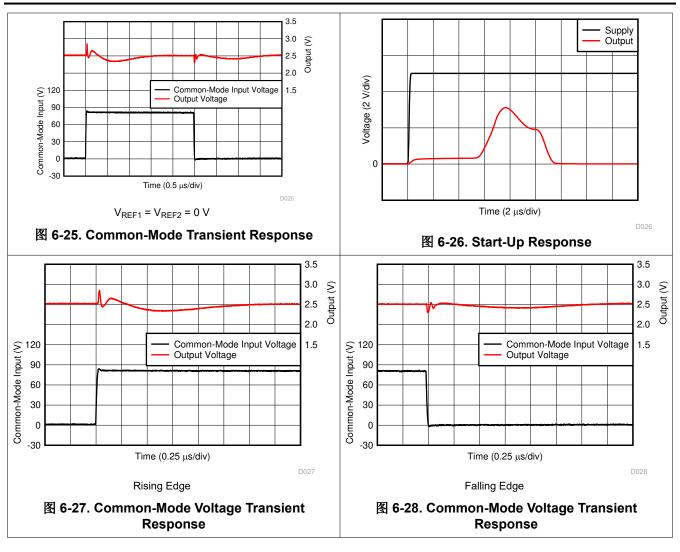


图 6-18. Quiescent Current vs Temperature





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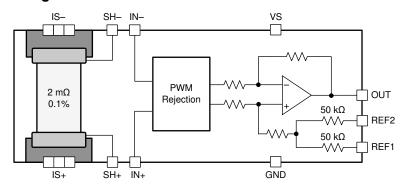


## 7 Detailed Description

#### 7.1 Overview

The INA253-Q1 features a precision,  $2\text{-m}\,\Omega$  current-sensing resistor and supports common mode voltages up to 80 V. The internal amplifier features a precision zero-drift topology with excellent common-mode rejection ratio (CMRR). The internal amplifier also features an enhanced pulse-width modulation (PWM) rejection current-sensing amplifier integrated into a single package. High-precision measurements are enabled by matching the shunt resistor value and the current-sensing amplifier gain, thus providing a highly-accurate, system-calibrated method for measuring current. Enhanced PWM rejection reduces the effect of common-mode transients on the output signal that are associated with PWM signals. Multiple gain versions are available to allow for the optimization of the desired full-scale output voltage based on the target current range expected in the application.

## 7.2 Functional Block Diagram



#### 7.3 Feature Description

#### 7.3.1 Integrated Shunt Resistor

The INA253-Q1 features a precise, low-drift, current-sensing resistor that provides accurate measurements over the entire specified temperature range of -40 °C to +125 °C. The integrated current-sensing resistor provides measurement stability over temperature, and simplifies printed circuit board (PCB) layout and board constraint difficulties common in high-precision measurements.

The onboard current-sensing resistor is designed as a 4-wire (or Kelvin) connected resistor that enables accurate measurements through a force-sense connection. Connecting the amplifier inputs pins (VIN – and VIN+) to the sense pins of the shunt resistor (SH – and SH+) eliminates many of the parasitic impedances commonly found in typical very-low sensing-resistor level measurements. Although the sense connection of the current-sensing resistor can be accessed through the SH+ and SH – pins, this resistor is not intended to be used as a stand-alone component. The INA253-Q1 is system-calibrated to makes sure that the current-sensing resistor and current-sensing amplifier are both precisely matched to one another. Use of the shunt resistor without the onboard amplifier results in a current-sensing resistor tolerance of approximately 5%. To achieve the optimized system gain specification, the onboard sensing resistor must be used with the internal current-sensing amplifier.

The INA253-Q1 has approximately  $4.5~m\,\Omega$  of package resistance. Of this total package resistance,  $2~m\,\Omega$  is a precisely-controlled resistance from the Kelvin-connected current-sensing resistor used by the amplifier. The power dissipation requirements of the system and package are based on the total  $4.5-m\,\Omega$  package resistance between the IS+ and IS – pins. The heat dissipated across the package when current flows through the device ultimately determines the maximum current that can be safely handled by the package. The current consumption of the silicon is relatively low, leaving the total package resistance to carry the high load current as the primary contributor to the total power dissipation of the package. The maximum safe-operating current level is set to make sure that the heat dissipated across the package is limited so that no damage occurs to the resistor or the package, or that the internal junction temperature of the silicon does not exceed a 150 °C limit.

External factors, such as ambient temperature, external air flow, and PCB layout, contribute to how effectively the device dissipates heat. The internal heat is developed as a result of the current flowing through the total

Product Folder Links: INA253-Q1

package resistance of 4.5 m  $\Omega$ . Under the conditions of no air flow, a maximum ambient temperature of 85 °C, and 1-oz. copper input power planes, the INA253-Q1 accommodates continuous current levels up to 15 A.  $\boxtimes$  7-1 shows that the current-handling capability is derated at temperatures greater than the 85 °C level, with safe operation up to 10 A at a 125 °C ambient temperature. With air flow and larger 2-oz. copper input power planes, the INA253-Q1 safely accommodates continuous current levels up to 15 A across the entire - 40 °C to +125 °C temperature range.

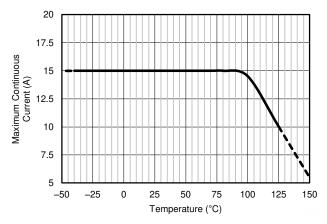


图 7-1. Maximum Continuous Current vs Temperature

#### 7.3.2 Short-Circuit Duration

The INA253-Q1 features a physical shunt resistance that is able to withstand current levels higher than the continuous handling limit of 15 A without sustaining damage to the current-sensing resistor or the current-sensing amplifier, if the excursions are brief. \$\infty\$ 7-2 shows the short-circuit duration curve for the INA253-Q1.

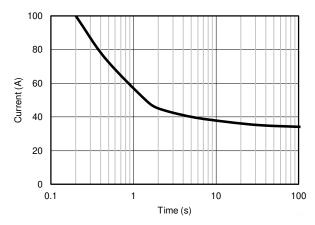


图 7-2. Short-Circuit Duration

#### 7.3.3 Temperature Stability

System calibration is common for many industrial applications in order to eliminate initial component and system-level errors that can be present. A system-level calibration reduces the initial accuracy requirement for many of the individual components because the errors associated with these components are effectively eliminated through the calibration procedure. This calibration enables precise measurements at the temperature in which the system is calibrated. As the system temperature changes because of external ambient changes or self heating, measurement errors are reintroduced. Without accurate temperature compensation used in addition to the initial adjustment, the calibration procedure is not effective. The user must account for temperature-induced changes. One of the primary benefits of the low temperature coefficient of the INA253-Q1 (including both the integrated current-sensing resistor and current-sensing amplifier) is that the device measurement remains accurate, even when the temperature changes throughout the specified temperature range of the device.

☑ 7-3 shows the drift performance for the integrated current-sensing resistor. Use ☑ 7-3 to determine the typical variance in the shunt resistor value at various temperatures. As with any resistive element, the tolerance of the component varies when exposed to different temperature conditions. For the current-sensing resistor integrated in the INA253-Q1, the resistor does vary slightly more when operated in temperatures ranging from -40 °C to 0 °C than when operated from 0 °C to 125 °C. Even in the -40 °C to 0 °C temperature range, the drift is still low at 25 ppm/°C.

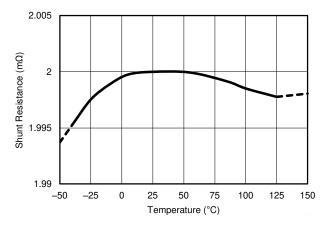


图 7-3. Sensing Resistor vs Temperature

An additional aspect to consider is that when current flows through the current-sensing resistor, power is dissipated across this component. This dissipated power results in an increase in the internal temperature of the package, including the integrated sensing resistor. This resistor self-heating effect results in an increase of the resistor temperature helping to move the component out of the colder, wider drift temperature region.

#### 7.3.4 Enhanced PWM Rejection Operation

The enhanced PWM rejection feature of the INA253-Q1 provides increased attenuation of large common-mode  $\Delta V/\Delta t$  transients. Large  $\Delta V/\Delta t$  common-mode transients associated with PWM signals are employed in applications such as motor or solenoid drive and switching power supplies. Traditionally, large  $\Delta V/\Delta t$  common-mode transitions are handled strictly by increasing the amplifier signal bandwidth, which can increase chip size, complexity and ultimately cost. The INA253-Q1 is designed with high common-mode rejection techniques to reduce large  $\Delta V/\Delta t$  transients before the system is disturbed as a result of these large signals. The high ac CMRR, in conjunction with signal bandwidth, allows the INA253-Q1 to provide minimal output transients and ringing compared with standard circuit approaches.

## 7.3.5 Input Signal Bandwidth

The INA253-Q1 input signal, which represents the current being measured, is accurately measured with minimal disturbance from large  $\Delta V/\Delta t$  common-mode transients as previously described. For PWM signals typically associated with motors, solenoids, and other switching applications, the current being monitored varies at a significantly slower rate than the faster PWM frequency.

The INA253-Q1 bandwidth is defined by the  $\,^-$  3-dB bandwidth of the current-sense amplifier inside the device; see  $\,^{\ddagger}$  6.5 for more information. The device bandwidth provides fast throughput and fast response required for the rapid detection and processing of overcurrent events. Without the higher bandwidth, protection circuitry may not have adequate response time, and damage may occur to the monitored application or circuit.

▼ 7-4 shows the performance profile of the device over frequency. Harmonic distortion increases at the upper end of the amplifier bandwidth with no adverse change in detection of overcurrent events. However, increased distortion at the highest frequencies must be considered when the measured current bandwidth begins to approach the INA253-Q1 bandwidth.

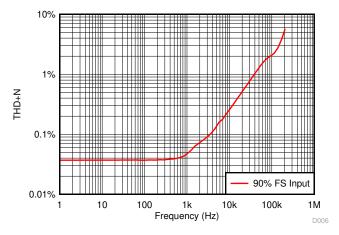


图 7-4. Amplifier Performance Over Frequency

For applications requiring distortion sensitive signals,  $\ensuremath{\mathbb{R}}$  7-4 provides information to show that there is an optimal frequency performance range for the amplifier. The full amplifier bandwidth is always available for fast overcurrent events at the same time that the lower-frequency signals are amplified at a low distortion level. The output signal accuracy is reduced for frequencies closer to the maximum bandwidth. Individual requirements determine the acceptable limits of distortion for high-frequency, current-sensing applications. Testing and evaluation in the end application or circuit are required to determine the acceptance criteria, and to validate the performance levels meet the system specifications.

#### 7.4 Device Functional Modes

#### 7.4.1 Adjusting the Output Midpoint With the Reference Pins

▼ 7-5 shows a test circuit for reference-divider accuracy. The INA253-Q1 output is configurable to allow for unidirectional or bidirectional operation.

▼ 7-5 shows a test circuit for reference-divider accuracy. The INA253-Q1 output is configurable to allow for unidirectional or bidirectional operation.

▼ 7-5 shows a test circuit for reference-divider accuracy.

▼ 7-6 shows a test circuit for reference-divider accuracy.

▼ 7-7 shows a test circuit for reference-divider accuracy.

▼ 7-7 shows a test circuit for reference-divider accuracy.

▼ 7-8 shows a test circuit for reference-divider accuracy.

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▼ 7-9 shows a test circuit for reference-divider accur

#### **CAUTION**

Do not connect the REF1 pin or the REF2 pin to any voltage source lower than GND or higher than  $V_{\rm S}$ .

The output voltage is set by applying a voltage or voltages to the reference voltage inputs, REF1 and REF2. The reference inputs are connected to an internal gain network. There is no operational difference between the two reference pins.

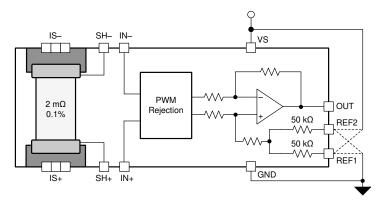


图 7-5. Adjusting the Output Midpoint

#### 7.4.2 Reference Pin Connections for Unidirectional Current Measurements

Unidirectional operation allows current measurements through a resistive shunt in one direction. For unidirectional operation, connect the device reference pins together and then to the negative rail (see † 7.4.3). The required differential input polarity depends on the output voltage setting. The amplifier output moves away from the referenced rail proportional to the current passing through the internal shunt resistor.

#### 7.4.3 Ground Referenced Output

When using the INA253-Q1 in unidirectional mode with a ground-referenced output, both reference inputs are connected to ground. 

7-6 shows how this configuration takes the output to ground when there is 0-A flowing across the internal shunt.

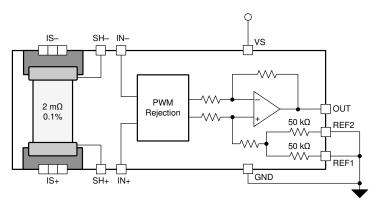


图 7-6. Ground-Referenced Output

#### 7.4.4 Reference Pin Connections for Bidirectional Current Measurements

Bidirectional operation allows the INA253-Q1 to measure currents through a resistive shunt in two directions. For this case, set the output voltage anywhere within the reference input limits. A common configuration is to set the reference inputs at half-scale for equal range in both directions. However, the reference inputs can be set to a voltage other than half-scale when the bidirectional current is nonsymmetrical.

#### 7.4.4.1 Output Set to External Reference Voltage

Connecting both pins together and then to a reference voltage results in an output voltage equal to the reference voltage for the condition of shorted input pins or a 0-V differential input. 🗵 7-7 shows this configuration. The output voltage decreases below the reference voltage when the IN+ pin is negative relative to the IN – pin, and increases when the IN+ pin is positive relative to the IN – pin. This technique is the most accurate way to bias the output to a precise voltage.

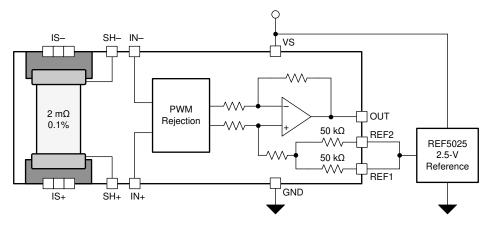


图 7-7. External Reference Output

#### 7.4.5 Output Set to Mid-Supply Voltage

 $\boxed{8}$  7-8 shows that by connecting one reference pin to VS and the other to the GND pin, the output is set at half of the supply when there is no differential input. This method creates a ratiometric offset to the supply voltage, where the output voltage remains at  $V_S$  / 2 when 0 V is applied between the IN+ and IN - inputs.

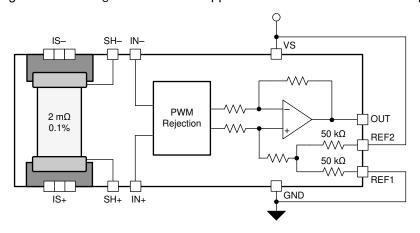


图 7-8. Mid-Supply Voltage Output

#### 7.4.6 Output Set to Mid-External Reference

In this example, an external reference is divided by two by connecting one REF pin to ground and the other REF pin to the reference, as shown in  $\boxed{3}$  7-9.

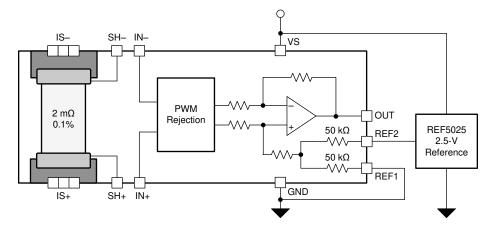


图 7-9. Mid-External Reference Output

## 7.4.7 Output Set Using Resistor Divide

The INA253-Q1 REF1 and REF2 pins allow for the midpoint of the output voltage to be adjusted for system circuitry connections to analog to digital converters (ADCs) or other amplifiers. The REF pins are designed to be connected directly to supply, ground, or a low-impedance reference voltage. The REF pins can be connected together and biased using a resistor divider to achieve a custom output voltage. If the amplifier is used in this configuration, as shown in  $\boxed{3}$  7-10, use the output as a differential signal with respect to the resistor divider voltage. For most accurate results, do not use single-ended measurements at the amplifier output because the internal impedance shifts can adversely affect device performance specifications.

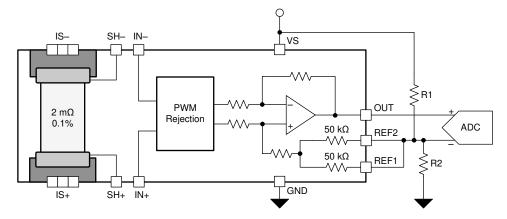


图 7-10. Setting the Reference Using a Resistor Divider

## 8 Application and Implementation

#### Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

## **8.1 Application Information**

The INA253-Q1 measures the voltage developed as current flows across the integrated low inductive current-sensing resistor. The device provides reference pins to configure operation as either unidirectional or bidirectional output swing. When using the INA253-Q1 for inline motor current sense or measuring current in an H-bridge, the device is commonly configured for bidirectional operation.

#### 8.1.1 Input Filtering

#### **Note**

Input filters are not required for accurate measurements using the INA253-Q1. For most accurate results, do not use filters at the IN+ and IN - inputs. However, If filter components are used on the input of the amplifier, follow the guidelines in this section to minimize effects on performance.

Based strictly on user design requirements, external filtering of the current signal may be desired. The initial location that can be considered for the filter is at the output of the current amplifier. Although placing the filter at the output satisfies the filtering requirements, this location changes the low output impedance measured by any circuitry connected to the output voltage pin. The other location for filter placement is at the current amplifier input pins. This location also satisfies the filtering requirement, but carefully select the components to minimize the impact on device performance. 

8-1 shows a filter placed at the inputs pins.

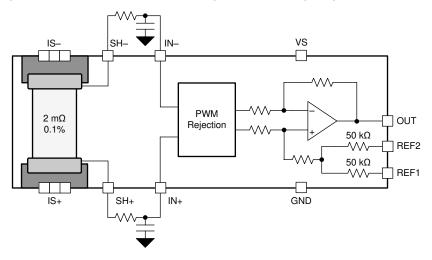


图 8-1. Filter at Input Pins

External series resistance provides a source of additional measurement error. Therefore, keep the value of these series resistors to 10- $\Omega$  or less in order to reduce loss of accuracy. The internal bias network shown in 8-1 creates a mismatch in input bias currents when a differential voltage is applied between the input pins (see 8-1). If additional external series filter resistors are added to the circuit, a mismatch is created in the voltage drop across the filter resistors. This voltage is a differential error voltage in the shunt resistor voltage. In addition to the absolute resistor value, mismatch resulting from resistor tolerance can significantly impact the error because this value is calculated based on the actual measured resistance.

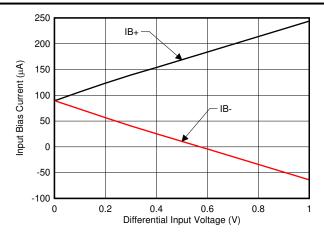


图 8-2. Input Bias Current vs Differential Input Voltage

Calculate the measurement error expected from the additional external filter resistors using 方程式 1.

Gain Error (%) = 
$$100 - (100 \times Gain Error Factor)$$
 (1)

#### where

• Gain Error Factor is calculated using 方程式 2.

Gain Error Factor = 
$$\frac{3000}{R_S + 3000}$$
 (2)

#### Where:

R<sub>S</sub> is the external filter resistance value

Calculate the gain error factor, shown in 方程式 2, in order to determine the gain error introduced by the additional external series resistance. 方程式 1 calculates the deviation of the shunt voltage resulting from the attenuation and imbalance created by the added external filter resistance. 表 8-1 provides the gain error factor and gain error for several resistor values.

表 8-1. Gain Error Factor and Gain Error for External Input Resistors

EXTERNAL RESISTANCE ( $\Omega$ )	GAIN ERROR FACTOR	GAIN ERROR (%)
5	0.998	0.17
10	0.997	0.33
100	0.968	3.23

## 8.2 Typical Applications

The INA253-Q1 offers advantages for multiple applications including the following:

- High common-mode range and excellent CMRR enables direct inline sensing
- · Precision low-inductive, low-drift shunt eliminates the need for overtemperature system calibration
- Ultra-low offset and drift eliminates the necessity of calibration
- Wide supply range enables a direct interface with most microprocessors

#### 8.2.1 High-Side, High-Drive, Solenoid Current-Sense Application

Challenges exist in solenoid drive current sensing that are similar to those in motor inline current sensing. In certain topologies, the current-sensing amplifier is exposed to the full-scale PWM voltage between ground and supply. The INA253-Q1 is an excellent choice for this type of application. The 2-m  $\Omega$  integrated shunt with a total system accuracy of 0.2% with a total system drift of 25 ppm/°C provides system accuracy across temperature eliminating the need for tri temperature system calibration.

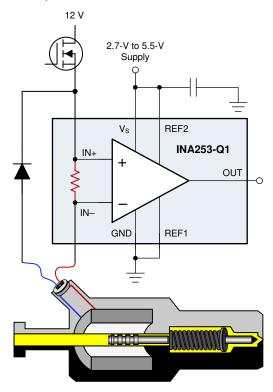


图 8-3. Solenoid Drive Application Circuit

#### 8.2.1.1 Design Requirements

For this application, the INA253-Q1 measures current in the driver circuit of a 12-V, 500-mA hydraulic valve.

表 8-2. Design Parameters

DESIGN PARAMETER	EXAMPLE VALUE
Common-mode voltage	12 V
Maximum sense current	500 mA
Power-supply voltage	3.3 V

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#### 8.2.1.2 Detailed Design Procedure

To demonstrate the performance of the device, the INA253-Q1, with a gain of 400mV/A, is selected for this design and powered from a 5-V supply.

Using the information in the # 7.4.5 section, the reference point is set to midscale by splitting the supply with REF1 connected to ground and REF2 connected to supply. Alternatively, the reference pins can be tied together and driven with an external precision reference.

#### 8.2.1.3 Application Curve

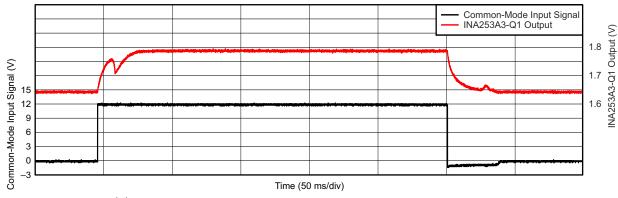


图 8-4. Solenoid Drive Current Sense Input and Output Signals

#### 8.2.2 Speaker Enhancements and Diagnostics Using Current Sense Amplifier

CLASS-D audio amplifiers in conjunction with the INA253-Q1 provide accurate speaker load current. Speaker load current is used to determine speaker diagnostics, and can further be expanded to measure key speaker parameters, such as speaker coil resistance and speaker real-time ambient temperature.

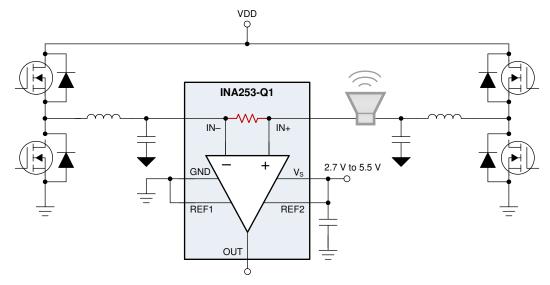


图 8-5. Current Sensing in a CLASS-D Subsystem

#### 8.2.2.1 Design Requirements

表 8-3. Design Parameters

• • • • • • • • • • • • • • • • • • • •					
DESIGN PARAMETER	EXAMPLE VALUE				
Common-mode voltage	24 V				
Power-supply voltage	5 V				
Maximum rms current	5 A				
Frequency sweep	20 Hz to 20 Khz				

## 8.2.2.2 Detailed Design Procedure

For this application, the INA253-Q1 measures current flowing through the speaker from the CLASS-D amplifier. The integrated shunt of 2 m $\Omega$  with an inductance of only 3 nH is an excellent choice for current sensing in speaker applications where low inductance is required. The low-inductive shunt enables accurate current sensing across frequencies over the audio range of 20 hz to 20 kHz.

The INA253-Q1 is setup in a bidirectional with the reference set to mid-supply as shown in <a>8</a> 7-9. The power supply to INA253-Q1 is setup at 5 V. The output of INA253-Q1 is set at 2.5 V. The INA253-Q1 with a gain of 100 mV/A, the INA253-Q1 output for a peak to peak of 10-A current the output of the INA253-Q1 will swing from 3.5 V to 1.5 V. The output can be directly connected to ADC input that has a full scale range of 5 V. The INA253-Q1 has a low THD+N of 0.1% at 1 kHz that enables distortion measurement of speaker. The INA253-Q1 can measure the impedance of the speaker and accurately measure the resonance frequency and peak impedance at resonance frequency. The INA253-Q1 can accurately track changes in impedance real time.

## 8.2.2.3 Application Curve

A typical example output response of speaker of 4- $\Omega$  impedance measurement from 20 Hz to 20 kHz is as shown in 8 8-6.

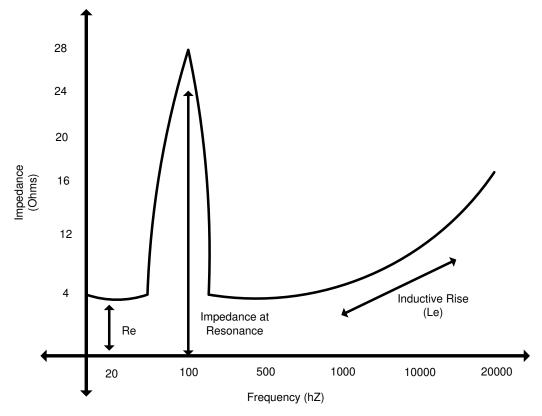


图 8-6. Speaker Impedance Measurement

## 9 Power Supply Recommendations

The INA253-Q1 makes accurate measurements beyond the connected power-supply voltage ( $V_S$ ) because the inputs (IN+ and IN  $^-$ ) operate anywhere between  $^-$  4 V and +80 V, independent of  $V_S$ . For example, the  $V_S$  power supply equals 5 V and the common-mode voltage of the measured shunt can be as high as 80 V. Although the common-mode voltage of the input can be beyond the supply voltage, the output voltage range of the INA253-Q1 is constrained to the supply voltage.

Place the power-supply bypass capacitor as close as possible to the supply and ground pins. The recommended value of this bypass capacitor is 0.1  $\mu$  F. Additional decoupling capacitance can be added to compensate for noisy or high-impedance power supplies. If the INA253-Q1 output is set to mid-supply, then take extreme care to minimize noise on the power supply.



## 10 Layout

## 10.1 Layout Guidelines

- This device is specified for current handling of up to 10 A over the entire 40 °C to +125 °C temperature range using a 1-oz copper pour for the input power plane, as well as no external airflow passing over the device.
- The primary current-handling limitation for this device is how much heat is dissipated inside the package. Efforts to improve heat transfer out of the package and into the surrounding environment improve the ability of the device to handle currents of up to 15 A over the entire 40 °C to +125 °C temperature range.
- Heat transfer improvements primarily involve larger copper power traces and planes with increased copper thickness (2 oz), as well as providing airflow to pass over the device. The INA253-Q1 evaluation module (EVM) features a 2-oz copper pour for the planes, and is capable of supporting 15 A at temperatures up to 125 °C.
- Place the power-supply bypass capacitor as close as possible to the supply and ground pins. The recommended value of this bypass capacitor is 0.1 µF. Additional decoupling capacitance can be added to compensate for noisy or high-impedance power supplies.

## 10.2 Layout Example

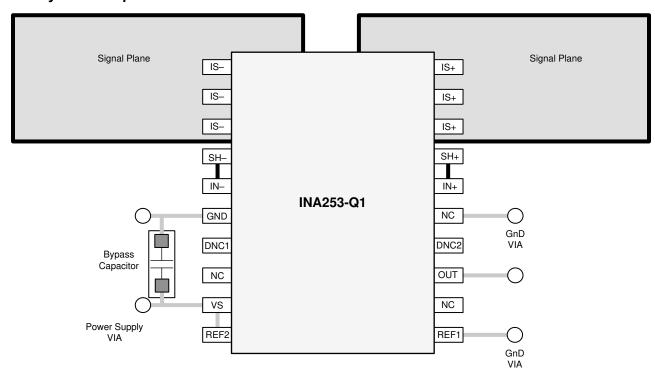


图 10-1. INA253-Q1 Layout Example

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## 11 Device and Documentation Support

## 11.1 Device Support

## 11.1.1 Development Support

INA253 Evaluation Module (EVM)

#### 11.2 Related Documentation

For related documentation see the following: Texas Instruments, INA253EVM user's guide

## 11.3 接收文档更新通知

要接收文档更新通知,请导航至 ti.com 上的器件产品文件夹。点击*订阅更新* 进行注册,即可每周接收产品信息更改摘要。有关更改的详细信息,请查看任何已修订文档中包含的修订历史记录。

## 11.4 支持资源

TI E2E<sup>™</sup> 支持论坛是工程师的重要参考资料,可直接从专家获得快速、经过验证的解答和设计帮助。搜索现有解答或提出自己的问题可获得所需的快速设计帮助。

链接的内容由各个贡献者"按原样"提供。这些内容并不构成 TI 技术规范,并且不一定反映 TI 的观点;请参阅 TI 的《使用条款》。

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ESD 的损坏小至导致微小的性能降级,大至整个器件故障。精密的集成电路可能更容易受到损坏,这是因为非常细微的参数更改都可能会导致器件与其发布的规格不相符。

## 11.7 术语表

TI术语表本术语表列出并解释了术语、首字母缩略词和定义。

#### 12 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

www.ti.com 9-Nov-2025

#### PACKAGING INFORMATION

Orderable part number	Status	Material type	Package   Pins	Package qty   Carrier	RoHS	Lead finish/	MSL rating/	Op temp (°C)	Part marking
	(1)	(2)			(3)	Ball material	Peak reflow		(6)
						(4)	(5)		
INA253A1QPWRQ1	Active	Production	TSSOP (PW)   20	2000   LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	Q253A1
INA253A1QPWRQ1.A	Active	Production	TSSOP (PW)   20	2000   LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	Q253A1
INA253A2QPWRQ1	Active	Production	TSSOP (PW)   20	2000   LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	Q253A2
INA253A2QPWRQ1.A	Active	Production	TSSOP (PW)   20	2000   LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	Q253A2
INA253A3QPWRQ1	Active	Production	TSSOP (PW)   20	2000   LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	Q253A3
INA253A3QPWRQ1.A	Active	Production	TSSOP (PW)   20	2000   LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	Q253A3

<sup>(1)</sup> Status: For more details on status, see our product life cycle.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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<sup>(2)</sup> Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

<sup>(3)</sup> RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

<sup>(4)</sup> Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

<sup>(5)</sup> MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

<sup>(6)</sup> Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

# **PACKAGE OPTION ADDENDUM**

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#### OTHER QUALIFIED VERSIONS OF INA253-Q1:

Catalog: INA253

NOTE: Qualified Version Definitions:

Catalog - TI's standard catalog product

# **PACKAGE MATERIALS INFORMATION**

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## TAPE AND REEL INFORMATION



# TAPE DIMENSIONS + K0 - P1 - B0 W Cavity - A0 -

A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

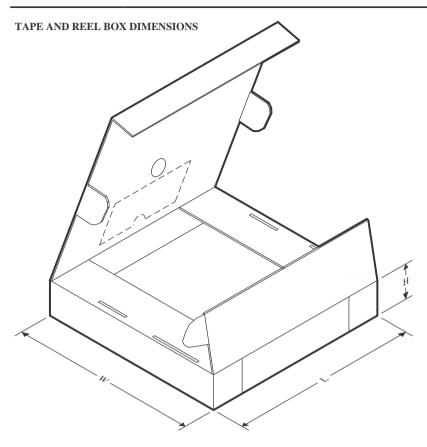
#### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
INA253A1QPWRQ1	TSSOP	PW	20	2000	330.0	16.4	6.95	7.0	1.4	8.0	16.0	Q1
INA253A2QPWRQ1	TSSOP	PW	20	2000	330.0	16.4	6.95	7.0	1.4	8.0	16.0	Q1
INA253A3QPWRQ1	TSSOP	PW	20	2000	330.0	16.4	6.95	7.0	1.4	8.0	16.0	Q1

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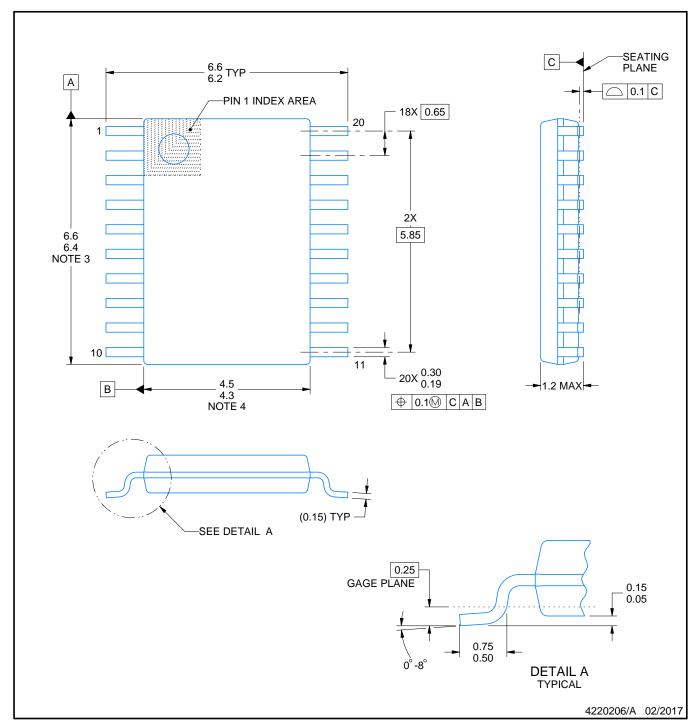


## \*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
INA253A1QPWRQ1	TSSOP	PW	20	2000	353.0	353.0	32.0
INA253A2QPWRQ1	TSSOP	PW	20	2000	353.0	353.0	32.0
INA253A3QPWRQ1	TSSOP	PW	20	2000	353.0	353.0	32.0



SMALL OUTLINE PACKAGE



#### NOTES:

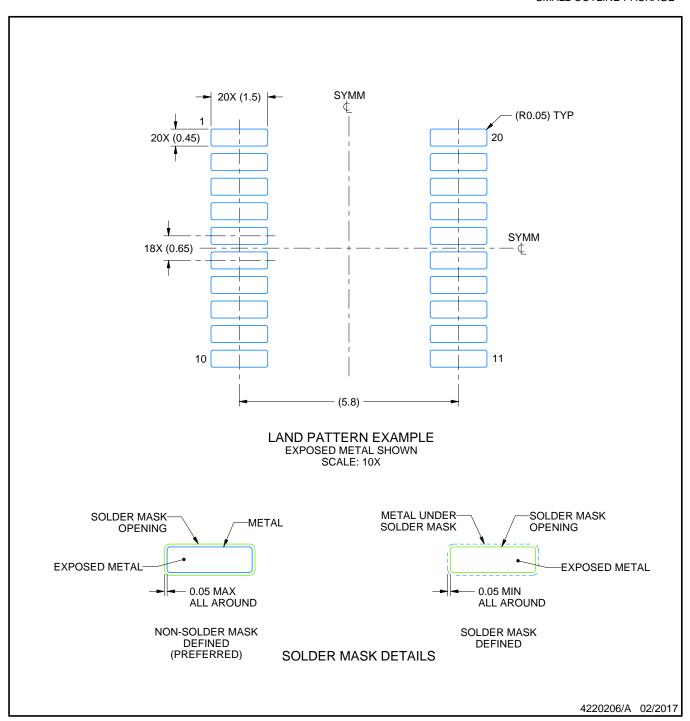
- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.



SMALL OUTLINE PACKAGE



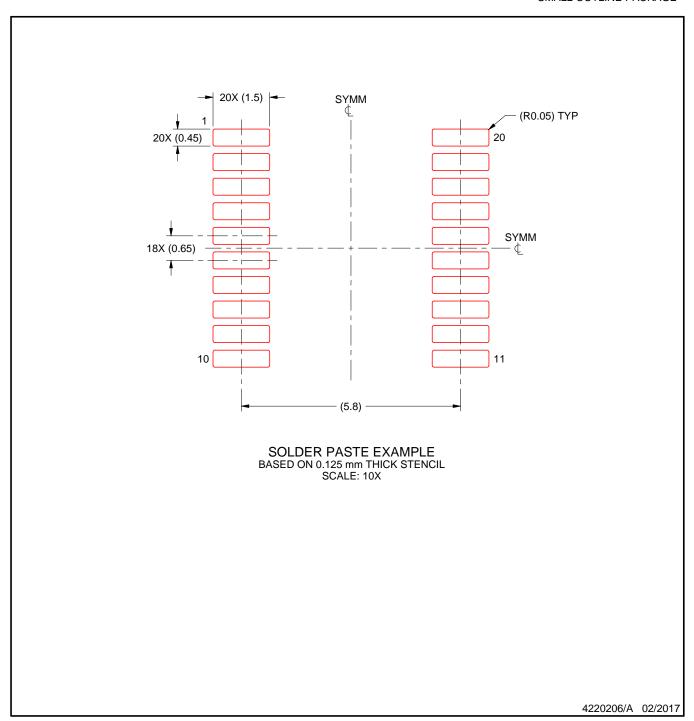
NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SMALL OUTLINE PACKAGE



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



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